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Feature Papers in Microelectronics

Guest Editors:

Dr. Alessandro Gabrielli

Prof. Dr. Paul Leroux

Dr. Gianluca Traversi

Prof. Dr. Lodovico Ratti

Deadline for manuscript submissions:

closed (1 April 2023)

Message from the Guest Editors

Analog, digital, mixed, radio frequency (RF), resonant, radiation-tolerant, low-power, in vivo and other integrated electronic topics are now expanding in the microelectronics market due to increasing global demand.

This Special Issue is dedicated to publishing original research (cutting-edge) reviews for the applications of microelectronics in emerging, frontier and challenging technologies. Electronics operating in extreme environments, such as vacuums, space, harsh radiation, extreme cold and other niche applications, are today pushing microelectronic design beyond the frontier of standard electronics.

Furthermore, as there is an expanding environment of software tools to facilitate microelectronic design, and to cope with large circuits composed of many hierarchical blocks, vendor IPs, multiclock trees, various physical interfaces of I/O and other specific blocks, the simulation environment is becoming increasingly strategic for integrated circuit (IC) submissions.

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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

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